18-bit Buffers / Drivers with 3-state Outputs

# HITACHI

ADE-205-172A (Z) 2nd. Edition December 1999

#### Description

The HD74ALVCH16825 improves the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The device can be used as two 9-bit buffers or one 18-bit buffer. It provides true data. The 3-state control gate is a 2-input AND gate with active low inputs so that if either output enable ( $\overline{OE1}$  or  $\overline{OE2}$ ) input is high, all nine affected outputs are in the high impedance state. Active bus hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

#### Features

- $V_{\rm CC} = 2.3 \text{ V}$  to 3.6 V
- Typical V<sub>OL</sub> ground bounce < 0.8 V (@V<sub>CC</sub> = 3.3 V, Ta = 25°C)
- Typical  $V_{OH}$  undershoot > 2.0 V (@V<sub>CC</sub> = 3.3 V, Ta = 25°C)
- High output current  $\pm 24 \text{ mA} (@V_{CC} = 3.0 \text{ V})$
- Bus hold on data inputs eliminates the need for external pullup / pulldown resistors

#### **Function Table**

Inputs			Output Y	
OE1	OE2	Α		
L	L	L	L	
L	L	Н	Н	
Н	Х	Х	Z	
Х	Н	Х	Z	

H : High level

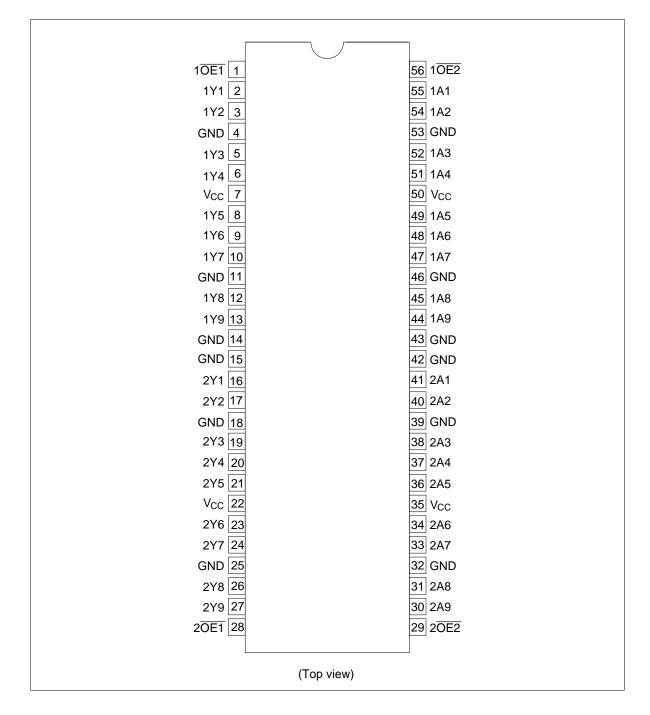
L : Low level

X : Immaterial

Z : High impedance



#### **Pin Arrangement**



Item Symbol		Ratings	Unit	Conditions	
Supply voltage	V <sub>cc</sub>	-0.5 to 4.6	V		
Input voltage <sup>*1</sup> V <sub>1</sub>		-0.5 to 4.6	V		
Output voltage *1, 2	Vo	–0.5 to V $_{\rm cc}$ +0.5	V		
Input clamp current	I <sub>IK</sub>	-50	mA	V <sub>1</sub> < 0	
Output clamp current	Ι <sub>οκ</sub>	±50	mA	$V_{o}$ < 0 or $V_{o}$ > $V_{cc}$	
Continuous output current	I <sub>o</sub>	±50	mA	$V_o = 0$ to $V_{cc}$	
		±100			
Maximum power dissipation at Ta = $55^{\circ}$ C (in still air) <sup>'3</sup>	P <sub>T</sub>	1	W	TSSOP	
Storage temperature	Tstg	-65 to 150	°C		

#### **Absolute Maximum Ratings**

Notes: Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

1. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

2. This value is limited to 4.6 V maximum.

3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

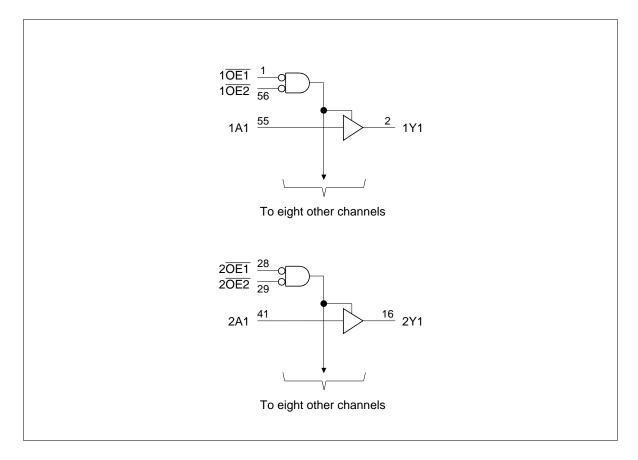
#### **Recommended Operating Conditions**

Item	Symbol	Min	Max	Unit	Conditions
Supply voltage	V <sub>cc</sub>	2.3	3.6	V	
Input voltage	V	0	V <sub>cc</sub>	V	
Output voltage	Vo	0	V <sub>cc</sub>	V	
High level output current	I <sub>он</sub>	—	-12	mA	$V_{cc} = 2.3 V$
		_	-12		$V_{cc} = 2.7 V$
		_	-24		V <sub>cc</sub> = 3.0 V
Low level output current	I <sub>ol</sub>	—	12	mA	$V_{cc}$ = 2.3 V
		_	12		$V_{cc} = 2.7 V$
		_	24		V <sub>cc</sub> = 3.0 V
Input transition rise or fall rate	$\Delta t / \Delta v$	0	10	ns / V	
Operating temperature	Та	-40	85	°C	

Note: Unused control inputs must be held high or low to prevent them from floating.

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# Logic Diagram



Item	Symbol	$V_{cc}(V)^{*1}$	Min	Max	Unit	Test Conditions
Input voltage	V <sub>IH</sub>	2.3 to 2.7	1.7	_	V	
		2.7 to 3.6	2.0	_	_	
	V <sub>IL</sub>	2.3 to 2.7	_	0.7	_	
		2.7 to 3.6	_	0.8	-	
Output voltage	V <sub>OH</sub>	Min to Max	V <sub>cc</sub> -0.2	_	V	I <sub>OH</sub> = -100 μA
		2.3	2.0	_	_	I <sub>OH</sub> = –6 mA, V <sub>IH</sub> = 1.7 V
		2.3	1.7	_	_	I <sub>OH</sub> = -12 mA, V <sub>IH</sub> = 1.7 V
		2.7	2.2	_	_	$I_{\rm OH} = -12$ mA, $V_{\rm IH} = 2.0$ V
		3.0	2.4	_		$I_{OH} = -12 \text{ mA}, V_{IH} = 2.0 \text{ V}$
		3.0	2.0	_		$I_{OH} = -24 \text{ mA}, V_{IH} = 2.0 \text{ V}$
	V <sub>OL</sub>	Min to Max	_	0.2		I <sub>oL</sub> = 100 μA
		2.3	_	0.4		$I_{oL} = 6 \text{ mA}, V_{IL} = 0.7 \text{ V}$
		2.3	_	0.7		I <sub>oL</sub> = 12 mA, V <sub>IL</sub> = 0.7 V
		2.7	_	0.4		I <sub>oL</sub> = 12 mA, V <sub>IL</sub> = 0.8 V
		3.0	_	0.55		I <sub>oL</sub> = 24 mA, V <sub>IL</sub> = 0.8 V
Input current	I <sub>IN</sub>	3.6	_	±5	μΑ	$V_{IN} = V_{CC}$ or GND
	I IN (hold)	2.3	45	_	_	V <sub>IN</sub> = 0.7 V
		2.3	-45	_		V <sub>IN</sub> = 1.7 V
		3.0	75	_		V <sub>IN</sub> = 0.8 V
		3.0	-75	_	_	V <sub>IN</sub> = 2.0 V
		3.6	_	±500		V <sub>IN</sub> = 0 to 3.6 V
Off state output current *2	² I <sub>oz</sub>	3.6	_	±10	μΑ	$V_{OUT} = V_{CC}$ or GND
Quiescent supply current	t I <sub>cc</sub>	3.6	_	40	μΑ	$V_{IN} = V_{CC}$ or GND
	$\Delta I_{\rm CC}$	3.0 to 3.6		750	μΑ	$V_{IN}$ = one input at (V <sub>cc</sub> -0.6) V, other inputs at V <sub>cc</sub> or GND

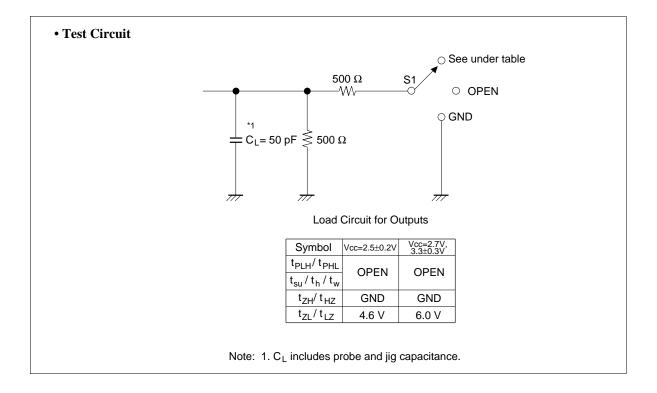
## **Electrical Characteristics** (Ta = -40 to $85^{\circ}$ C)

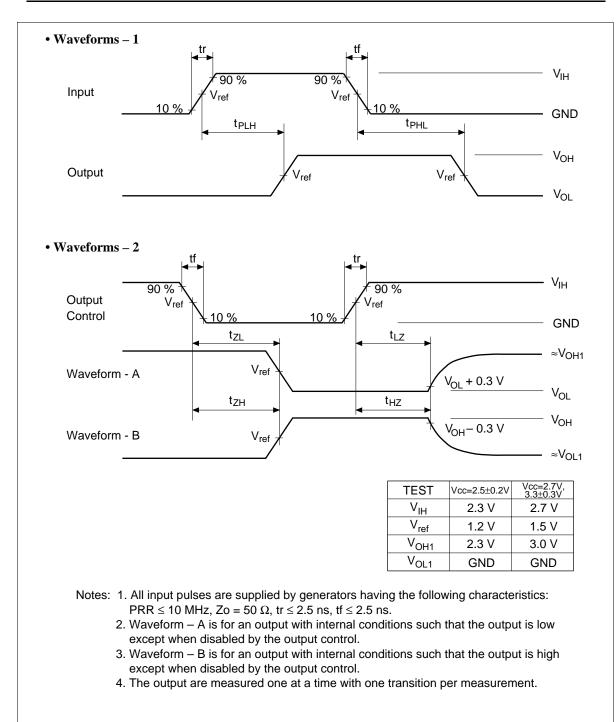
Notes: 1. For conditions shown as Min or Max, use the appropriate values under recommended operating conditions.

2. For I/O ports, the parameter  $\rm I_{\rm oz}$  includes the input leakage current.

#### **Switching Characteristics** (Ta = -40 to $85^{\circ}$ C)

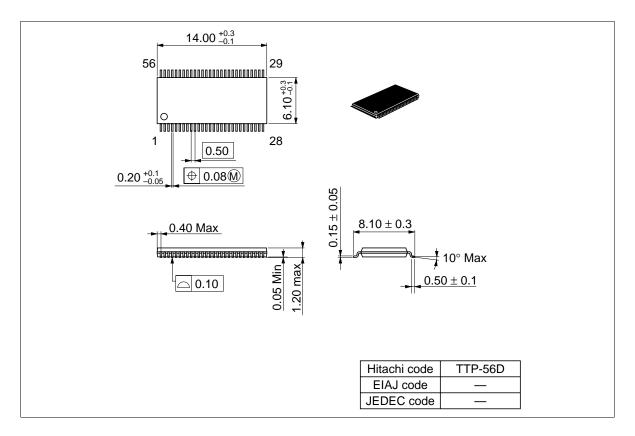
Item	Symbol	V <sub>cc</sub> (V)	Min	Тур	Max	Unit	FROM (Input)	TO (Output)
Propagation delay time	t <sub>PLH</sub>	2.5±0.2	1.0	_	4.1	ns	А	Y
	t <sub>PHL</sub>	2.7	—	_	3.9			
		3.3±0.3	1.0	_	3.4			
Output enable time	t <sub>zH</sub>	2.5±0.2	1.0	—	6.0	ns	ŌĒ	Y
	t <sub>zL</sub>	2.7	_	—	5.7			
		3.3±0.3	1.0	_	4.7			
Output disable time	t <sub>HZ</sub>	2.5±0.2	1.9	—	5.6	ns	ŌĒ	Y
	$t_{LZ}$	2.7	—	—	4.9			
		3.3±0.3	1.3	_	4.5			
Input capacitance	C <sub>IN</sub>	3.3	_	3.5	_	pF	Control inputs	
		3.3	_	6.0	_		Data inpu	its
Output capacitance	C <sub>o</sub>	3.3		7.5		pF	Outputs	





## **Package Dimensions**

Unit : mm



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